

**Notic of References Cited**

Application/Control No.

09/924,252

Applicant(s)/Patent Under  
Reexamination  
SYED ET AL.

Examiner

Tae H Yoon

Art Unit

1714

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,032,481	06-1977	Pillar, Walter O.	521/56
	B	US-6,017,986	01-2000	Burton, Lester P. J.	524/313
	C	US-6,046,273	04-2000	Syed, Abuzar	525/71
	D	US-6,107,377	08-2000	Nakamura et al.	524/153
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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